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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Discontinued at Digi-Key
Core Processor	CIP-51 8051
Core Size	8-Bit
Speed	50MHz
Connectivity	I ² C, SMBus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, POR, PWM, WDT
Number of I/O	28
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	2.25K x 8
Voltage - Supply (Vcc/Vdd)	2.2V ~ 3.6V
Data Converters	A/D 20x10/12b SAR; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	32-TQFP
Supplier Device Package	32-QFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/silicon-labs/efm8bb31f16g-a-qfp32r

1. Feature List

The EFM8BB3 device family are fully integrated, mixed-signal system-on-a-chip MCUs. Highlighted features are listed below.

- · Core:
 - Pipelined CIP-51 Core
 - · Fully compatible with standard 8051 instruction set
 - 70% of instructions execute in 1-2 clock cycles
 - · 50 MHz maximum operating frequency
- · Memory:
 - Up to 64 kB flash memory (63 kB user-accessible), in-system re-programmable from firmware in 512-byte sectors
 - Up to 4352 bytes RAM (including 256 bytes standard 8051 RAM and 4096 bytes on-chip XRAM)
- · Power:
 - · Internal LDO regulator for CPU core voltage
 - · Power-on reset circuit and brownout detectors
- I/O: Up to 29 total multifunction I/O pins:
 - · Up to 25 pins 5 V tolerant under bias
 - · Selectable state retention through reset events
 - · Flexible peripheral crossbar for peripheral routing
 - 5 mA source, 12.5 mA sink allows direct drive of LEDs
- · Clock Sources:
 - Internal 49 MHz oscillator with accuracy of ±1.5%
 - Internal 24.5 MHz oscillator with ±2% accuracy
 - Internal 80 kHz low-frequency oscillator
 - · External CMOS clock option
 - · External crystal/RC/C Oscillator (up to 25 MHz)

- · Analog:
 - 12/10-Bit Analog-to-Digital Converter (ADC)
 - · Internal temperature sensor
 - 2 x 12-Bit Digital-to-Analog Converters (DAC)
 - 2 x Low-current analog comparators with adjustable reference
- · Communications and Digital Peripherals:
 - 2 x UART, up to 3 Mbaud
 - SPI™ Master / Slave, up to 12 Mbps
 - SMBus™/I2C™ Master / Slave, up to 400 kbps
 - I²C High-Speed Slave, up to 3.4 Mbps
 - 16-bit CRC unit, supporting automatic CRC of flash at 256byte boundaries
 - · 4 Configurable Logic Units
- · Timers/Counters and PWM:
 - 6-channel programmable counter array (PCA) supporting PWM, capture/compare, and frequency output modes
 - 6 x 16-bit general-purpose timers
 - Independent watchdog timer, clocked from the low frequency oscillator
- · On-Chip, Non-Intrusive Debugging
 - · Full memory and register inspection
 - · Four hardware breakpoints, single-stepping

With on-chip power-on reset, voltage supply monitor, watchdog timer, and clock oscillator, the EFM8BB3 devices are truly standalone system-on-a-chip solutions. The flash memory is reprogrammable in-circuit, providing nonvolatile data storage and allowing field upgrades of the firmware. The on-chip debugging interface (C2) allows non-intrusive (uses no on-chip resources), full speed, in-circuit debugging using the production MCU installed in the final application. This debug logic supports inspection and modification of memory and registers, setting breakpoints, single stepping, and run and halt commands. All analog and digital peripherals are fully functional while debugging. Device operation is specified from 2.2 V up to a 3.6 V supply. Devices are AEC-Q100 qualified (pending) and available in 4x4 mm 32-pin QFN, 3x3 mm 24-pin QFN, 32-pin QFP, or 24-pin QSOP packages. All package options are lead-free and RoHS compliant.

3.7 Analog

12/10-Bit Analog-to-Digital Converter (ADC0)

The ADC is a successive-approximation-register (SAR) ADC with 12- and 10-bit modes, integrated track-and hold and a programmable window detector. The ADC is fully configurable under software control via several registers. The ADC may be configured to measure different signals using the analog multiplexer. The voltage reference for the ADC is selectable between internal and external reference sources.

- · Up to 20 external inputs
- Single-ended 12-bit and 10-bit modes
- Supports an output update rate of up to 400 ksps in 12-bit mode
- Channel sequencer logic with direct-to-XDATA output transfers
- · Operation in a low power mode at lower conversion speeds
- Asynchronous hardware conversion trigger, selectable between software, external I/O and internal timer and configurable logic sources
- · Output data window comparator allows automatic range checking
- · Support for output data accumulation
- Conversion complete and window compare interrupts supported
- Flexible output data formatting
- Includes a fully-internal fast-settling 1.65 V reference and an on-chip precision 2.4 / 1.2 V reference, with support for using the supply as the reference, an external reference and signal ground
- · Integrated temperature sensor

12-Bit Digital-to-Analog Converters (DAC0, DAC1, DAC2, DAC3)

The DAC modules are 12-bit Digital-to-Analog Converters with the capability to synchronize multiple outputs together. The DACs are fully configurable under software control. The voltage reference for the DACs is selectable between internal and external reference sources.

- · Voltage output with 12-bit performance
- Supports an update rate of 200 ksps
- · Hardware conversion trigger, selectable between software, external I/O and internal timer and configurable logic sources
- · Outputs may be configured to persist through reset and maintain output state to avoid system disruption
- · Multiple DAC outputs can be synchronized together
- DAC pairs (DAC0 and 1 or DAC2 and 3) support complementary output waveform generation
- Outputs may be switched between two levels according to state of configurable logic / PWM input trigger
- · Flexible input data formatting
- Supports references from internal supply, on-chip precision reference, or external VREF pin

3.10 Bootloader

All devices come pre-programmed with a UART0 bootloader. This bootloader resides in the code security page, which is the last page of code flash; it can be erased if it is not needed.

The byte before the Lock Byte is the Bootloader Signature Byte. Setting this byte to a value of 0xA5 indicates the presence of the bootloader in the system. Any other value in this location indicates that the bootloader is not present in flash.

When a bootloader is present, the device will jump to the bootloader vector after any reset, allowing the bootloader to run. The bootloader then determines if the device should stay in bootload mode or jump to the reset vector located at 0x0000. When the bootloader is not present, the device will jump to the reset vector of 0x0000 after any reset.

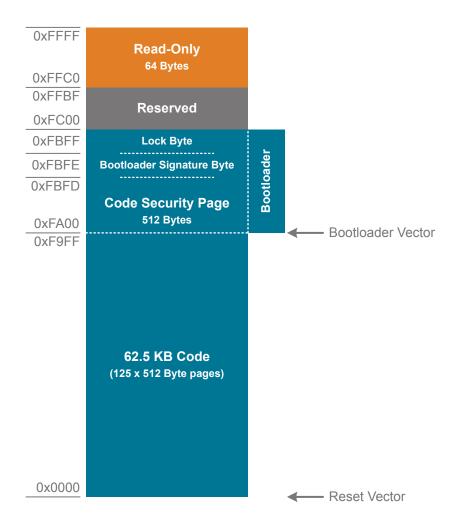


Figure 3.2. Flash Memory Map with Bootloader — 62.5 KB Devices

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Comparators (CMP0, CMP1)	I _{CMP}	CPMD = 11	_	0.5	_	μA
		CPMD = 10	_	3	_	μA
		CPMD = 01	_	10	_	μA
		CPMD = 00	_	25	_	μA
Comparator Reference	I _{CPREF}		_	TBD	_	μA
Voltage Supply Monitor (VMON0)	I _{VMON}		_	15	20	μA

Note:

- 1. Currents are additive. For example, where I_{DD} is specified and the mode is not mutually exclusive, enabling the functions increases supply current by the specified amount.
- 2. Includes supply current from internal LDO regulator, supply monitor, and High Frequency Oscillator.
- 3. Includes supply current from internal LDO regulator, supply monitor, and Low Frequency Oscillator.
- 4. ADC0 power excludes internal reference supply current.
- 5. The internal reference is enabled as-needed when operating the ADC in low power mode. Total ADC + Reference current will depend on sampling rate.
- 6. DAC supply current for each enabled DA and not including external load on pin.

4.1.3 Reset and Supply Monitor

Table 4.3. Reset and Supply Monitor

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
VDD Supply Monitor Threshold V _{VDDM}			1.85	1.95	2.1	V
Power-On Reset (POR) Threshold	V _{POR}	Rising Voltage on VDD	_	1.4	_	V
		Falling Voltage on VDD	0.75	_	1.36	V
VDD Ramp Time	t _{RMP}	Time to V _{DD} > 2.2 V	10	_	_	μs
Reset Delay from POR	t _{POR}	Relative to V _{DD} > V _{POR}	3	10	31	ms
Reset Delay from non-POR source	t _{RST}	Time between release of reset source and code execution	_	50	_	μs
RST Low Time to Generate Reset	t _{RSTL}		15	_	_	μs
Missing Clock Detector Response Time (final rising edge to reset)	t _{MCD}	F _{SYSCLK} >1 MHz	_	0.625	1.2	ms
Missing Clock Detector Trigger Frequency	F _{MCD}		_	7.5	13.5	kHz
VDD Supply Monitor Turn-On Time	t _{MON}		_	2	_	μs

4.1.4 Flash Memory

Table 4.4. Flash Memory

Parameter	Symbol	Test Condition	Min	Тур	Max	Units
Write Time ¹ , ²	t _{WRITE}	One Byte,	19	20	21	μs
		F _{SYSCLK} = 24.5 MHz				
Erase Time ¹ , ²	t _{ERASE}	One Page,	5.2	5.35	5.5	ms
		F _{SYSCLK} = 24.5 MHz				
V _{DD} Voltage During Programming ³	V _{PROG}		2.2	_	3.6	V
Endurance (Write/Erase Cycles)	N _{WE}		20k	100k	_	Cycles

Note:

- 1. Does not include sequencing time before and after the write/erase operation, which may be multiple SYSCLK cycles.
- 2. The internal High-Frequency Oscillator 0 has a programmable output frequency, which is factory programmed to 24.5 MHz. If user firmware adjusts the oscillator speed, it must be between 22 and 25 MHz during any flash write or erase operation. It is recommended to write the HFO0CAL register back to its reset value when writing or erasing flash.
- 3. Flash can be safely programmed at any voltage above the supply monitor threshold (V_{VDDM}).
- 4. Data Retention Information is published in the Quarterly Quality and Reliability Report.

4.1.5 Power Management Timing

Table 4.5. Power Management Timing

Parameter	Symbol	Test Condition	Min	Тур	Max	Units
Idle Mode Wake-up Time	t _{IDLEWK}		2	_	3	SYSCLKs
Suspend Mode Wake-up Time	t _{SUS-} PENDWK	SYSCLK = HFOSC0 CLKDIV = 0x00	_	170	_	ns
Snooze Mode Wake-up Time	t _{SLEEPWK}	SYSCLK = HFOSC0 CLKDIV = 0x00	_	12	_	μs

4.1.6 Internal Oscillators

Table 4.6. Internal Oscillators

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit			
High Frequency Oscillator 0 (24.5 MHz)									
Oscillator Frequency	f _{HFOSC0}	Full Temperature and Supply Range	24	24.5	25	MHz			
Power Supply Sensitivity	PSS _{HFOS}	T _A = 25 °C	_	0.5	_	%/V			
Temperature Sensitivity	TS _{HFOSC0}	V _{DD} = 3.0 V	_	40	_	ppm/°C			
High Frequency Oscillator 1 (49 MH	lz)		I		ı	1			
Oscillator Frequency	f _{HFOSC1}	Full Temperature and Supply Range	48.25	49	49.75	MHz			
Power Supply Sensitivity	PSS _{HFOS}	T _A = 25 °C	_	TBD	_	%/V			
Temperature Sensitivity	TS _{HFOSC1}	V _{DD} = 3.0 V	_	TBD	_	ppm/°C			
Low Frequency Oscillator (80 kHz)			I		ı	1			
Oscillator Frequency f _{LFOSC}		Full Temperature and Supply Range	75	80	85	kHz			
Power Supply Sensitivity	PSS _{LFOSC}	T _A = 25 °C	_	0.05	_	%/V			
Temperature Sensitivity TS _{LFOSC} V _D		V _{DD} = 3.0 V	_	65	_	ppm/°C			

4.1.7 External Clock Input

Table 4.7. External Clock Input

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
External Input CMOS Clock	f _{CMOS}		0	_	50	MHz
Frequency (at EXTCLK pin)						
External Input CMOS Clock High Time	t _{CMOSH}		9	_	_	ns
External Input CMOS Clock Low Time	t _{CMOSL}		9	_	_	ns

4.1.8 Crystal Oscillator

Table 4.8. Crystal Oscillator

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Crystal Frequency	f _{XTAL}		0.02	_	25	MHz
Crystal Drive Current	I _{XTAL}	XFCN = 0	_	0.5	_	μΑ
		XFCN = 1	_	1.5	_	μA
		XFCN = 2	_	4.8	_	μΑ
		XFCN = 3	_	14	_	μΑ
		XFCN = 4	_	40	_	μΑ
		XFCN = 5	_	120	_	μΑ
		XFCN = 6	_	550	_	μА
		XFCN = 7	_	2.6	_	mA

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Offset Temperature Coefficient	TC _{OFF}		_	TBD	_	LSB/°C
Slope Error	E _M	12 Bit Mode	_	TBD	TBD	%
		10 Bit Mode	_	TBD	_	%
Dynamic Performance 10 kHz Sine	Wave Input	1 dB below full scale, Max throughput	, using AGN	D pin		
Signal-to-Noise	SNR	12 Bit Mode	_	TBD	_	dB
		10 Bit Mode	_	TBD	_	dB
Signal-to-Noise Plus Distortion	SNDR	12 Bit Mode	TBD	TBD	_	dB
		10 Bit Mode	_	TBD	_	dB
Total Harmonic Distortion (Up to	THD	12 Bit Mode	_	TBD	_	dB
5th Harmonic)		10 Bit Mode	_	TBD	_	dB
Spurious-Free Dynamic Range	SFDR	12 Bit Mode	_	TBD	_	dB
		10 Bit Mode	_	TBD	_	dB

Note:

1. Conversion Time does not include Tracking Time. Total Conversion Time is:

Total Conversion Time = [RPT × (ADTK + NUMBITS + 1) × T(SARCLK)] + (T(ADCCLK) × 4)

where RPT is the number of conversions represented by the ADRPT field and ADCCLK is the clock selected for the ADC.

2. Absolute input pin voltage is limited by the $V_{\mbox{\scriptsize IO}}$ supply.

4.1.12 DACs

Table 4.12. DACs

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Resolution	N _{bits}			12		Bits
Throughput Rate	f _S		_	_	200	ksps
Integral Nonlinearity	INL		TBD	±0.5	TBD	LSB
Differential Nonlinearity	DNL		TBD	±5	TBD	LSB
Output Noise	VREF = 2.4 V f _S = 0.1 Hz to 300 kHz		_	110	_	μV _{RMS}
Slew Rate	SLEW		_	±1	_	V/µs
Output Settling Time to 1 LSB	tsettle	V _{OUT} change between 25% and 75% Full Scale	_	2.6	5	μs
Power-on Time	t _{PWR}		_	_	10	μs
Voltage Reference Range	V _{REF}		1.15	_	V _{DD}	V
Power Supply Rejection Ratio	PSRR	DC, V _{OUT} = 50% Full Scale	_	110	_	dB
		1 kHz, V _{OUT} = 50% Full Scale	_	60	_	dB
Total Harmonic Distortion	THD	V _{OUT} = 10 kHz sine wave, 10% to 90%	60	_	_	dB
Offset Error	E _{OFF}	VREF = 2.4 V	TBD	±0.5	TBD	LSB
Offset Temperature Coefficient	TC _{OFF}		_	TBD	_	ppm/°C
Full-Scale Error	E _{FS}	VREF = 2.4 V	TBD	±5	TBD	LSB
Full-Scale Error Tempco	TC _{FS}		_	TBD	_	ppm/°C
External Load Impedance	R _{LOAD}		2	_	_	kΩ
External Load Capacitance	C _{LOAD}		TBD	_	100	pF
Load Regulation		V _{OUT} = 50% Full Scale	_	100	TBD	μV/mA

Pin Number	Pin Name	Description	Crossbar Capability	Additional Digital Functions	Analog Functions
18	P1.7	Multifunction I/O	Yes	P1MAT.7	ADC0.13
				CLU0B.15	CMP0P.9
				CLU1B.13	CMP0N.9
				CLU2A.13	
19	P1.6	Multifunction I/O	Yes	P1MAT.6	ADC0.12
				CLU0A.15	
				CLU1B.12	
				CLU2A.12	
20	P1.5	Multifunction I/O	Yes	P1MAT.5	ADC0.11
				CLU0B.14	
				CLU1A.13	
				CLU2B.13	
				CLU3B.11	
21	P1.4	Multifunction I/O	Yes	P1MAT.4	ADC0.10
				CLU0A.14	
				CLU1A.12	
				CLU2B.12	
				CLU3B.10	
22	P1.3	Multifunction I/O	Yes	P1MAT.3	ADC0.9
				CLU0B.13	
				CLU1B.11	
				CLU2B.11	
				CLU3A.13	
23	P1.2	Multifunction I/O	Yes	P1MAT.2	ADC0.8
				CLU0A.13	CMP0P.8
				CLU1A.11	CMP0N.8
				CLU2B.10	
				CLU3A.12	
				CLU3B.13	
24	P1.1	Multifunction I/O	Yes	P1MAT.1	ADC0.7
				CLU0B.12	CMP0P.7
				CLU1B.10	CMP0N.7
				CLU2A.11	
				CLU3B.12	

Pin Number	Pin Name	Description	Crossbar Capability	Additional Digital Functions	Analog Functions
12	P1.5	Multifunction I/O	Yes	P1MAT.5	ADC0.10
				CLU2OUT	CMP1P.4
				CLU0B.14	CMP1N.4
				CLU1A.13	
				CLU2B.13	
				CLU3B.11	
13	P1.4	Multifunction I/O	Yes	P1MAT.4	ADC0.9
				I2C0_SCL	CMP1P.3
				CLU0A.14	CMP1N.3
				CLU1A.12	
				CLU2B.12	
				CLU3B.10	
14	P1.3	Multifunction I/O	Yes	P1MAT.3	CMP1P.2
				I2C0_SDA	CMP1N.2
				CLU0B.13	
				CLU1B.11	
				CLU2B.11	
				CLU3A.13	
15	GND	Ground			
16	P1.2	Multifunction I/O	Yes	P1MAT.2	ADC0.8
				CLU0A.13	
				CLU1A.11	
				CLU2B.10	
				CLU3A.12	
				CLU3B.13	
17	P1.1	Multifunction I/O	Yes	P1MAT.1	ADC0.7
				CLU0B.12	
				CLU1B.10	
				CLU2A.11	
				CLU3B.12	
18	P1.0	Multifunction I/O	Yes	P1MAT.0	ADC0.6
				CLU0A.12	
				CLU1A.10	
				CLU2A.10	

6.4 EFM8BB3x-QSOP24 Pin Definitions

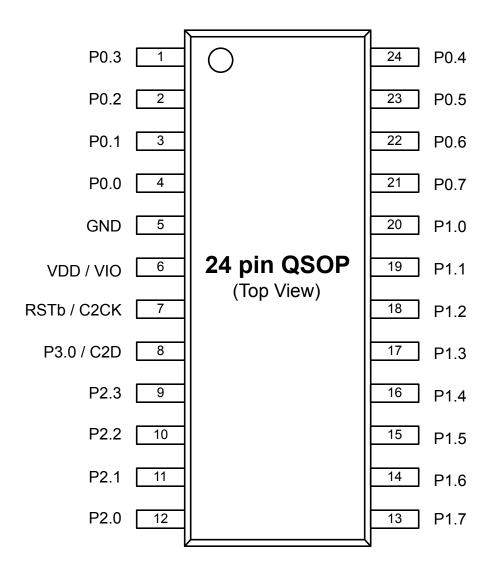


Figure 6.4. EFM8BB3x-QSOP24 Pinout

Table 6.4. Pin Definitions for EFM8BB3x-QSOP24

Pin Number	Pin Name	Description	Crossbar Capability	Additional Digital Functions	Analog Functions
1	P0.3	Multifunction I/O	Yes	P0MAT.3	XTAL2
				EXTCLK	
				INT0.3	
				INT1.3	
				CLU0B.9	
				CLU2B.10	
				CLU3A.9	

Pin Number	Pin Name	Description	Crossbar Capability	Additional Digital Functions	Analog Functions
2	P0.2	Multifunction I/O	Yes	P0MAT.2	XTAL1
				INT0.2	ADC0.1
				INT1.2	CMP0P.1
				CLU0OUT	CMP0N.1
				CLU0A.9	
				CLU2B.8	
				CLU3A.8	
3	P0.1	Multifunction I/O	Yes	P0MAT.1	ADC0.0
				INT0.1	CMP0P.0
				INT1.1	CMP0N.0
				CLU0B.8	AGND
				CLU2A.9	
				CLU3B.9	
4	P0.0	Multifunction I/O	Yes	P0MAT.0	VREF
				INT0.0	
				INT1.0	
				CLU0A.8	
				CLU2A.8	
				CLU3B.8	
5	GND	Ground			
6	VDD / VIO	Supply Power Input			
7	RSTb /	Active-low Reset /			
	C2CK	C2 Debug Clock			
8	P3.0 /	Multifunction I/O /			
	C2D	C2 Debug Data			
9	P2.3	Multifunction I/O	Yes	P2MAT.3	DAC3
				CLU1B.15	
				CLU2B.15	
				CLU3A.15	
10	P2.2	Multifunction I/O	Yes	P2MAT.2	DAC2
				CLU1A.15	
				CLU2B.14	
				CLU3A.14	

Pin Number	Pin Name	Description	Crossbar Capability	Additional Digital Functions	Analog Functions
24	P0.4	Multifunction I/O	Yes	P0MAT.4	ADC0.2
				INT0.4	CMP0P.2
				INT1.4	CMP0N.2
				UARTO_TX	
				CLU0A.10	
				CLU1A.8	

7. QFN32 Package Specifications

7.1 QFN32 Package Dimensions

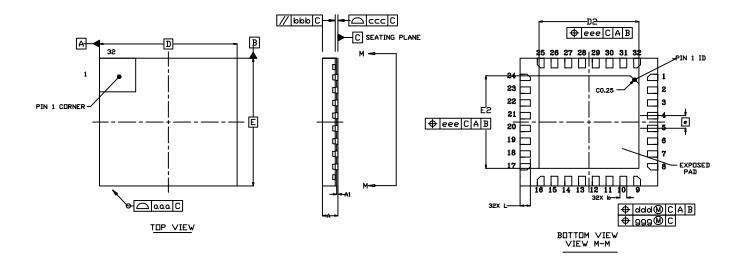


Figure 7.1. QFN32 Package Drawing

Table 7.1. QFN32 Package Dimensions

Dimension	Min	Тур	Max	
A	0.45	0.50	0.55	
A1	0.00	0.035	0.05	
b	0.15	0.20	0.25	
D		4.00 BSC.		
D2	2.80	2.90	3.00	
е	0.40 BSC.			
Е	4.00 BSC.			
E2	2.80	2.90	3.00	
L	0.20	0.30	0.40	
aaa	_	_	0.10	
bbb	_	_	0.10	
ccc	_	_	0.08	
ddd	_	_	0.10	
eee	_	_	0.10	
999	_	_	0.05	

Dimension	Min	Тур	Max
aaa	0.20		
bbb		0.20	
ccc	0.10		
ddd	0.20		
theta	0°	3.5°	7°

Note:

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.
- 3. This drawing conforms to JEDEC outline MS-026.
- 4. Recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

8.2 QFP32 PCB Land Pattern

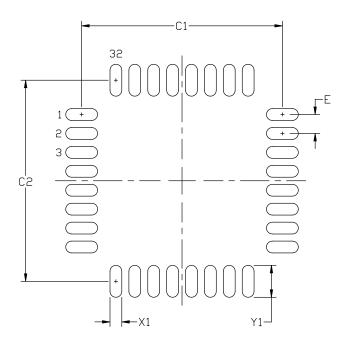


Figure 8.2. QFP32 PCB Land Pattern Drawing

Table 8.2. QFP32 PCB Land Pattern Dimensions

Dimension	Min	Max	
C1	8.40	8.50	
C2	8.40	8.50	
Е	0.80 BSC		
X1	0.55		
Y1	1.5		

Note:

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. This Land Pattern Design is based on the IPC-7351 guidelines.
- 3. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be $60 \mu m$ minimum, all the way around the pad.
- 4. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 5. The stencil thickness should be 0.125 mm (5 mils).
- 6. The ratio of stencil aperture to land pad size should be 1:1 for all perimeter pads.
- 7. A No-Clean, Type-3 solder paste is recommended.
- 8. The recommended card reflow profile is per the JEDEC/IPC J-STD-020C specification for Small Body Components.

9. QFN24 Package Specifications

9.1 QFN24 Package Dimensions

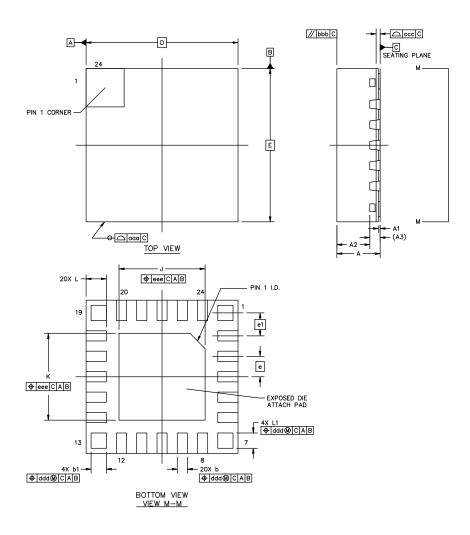


Figure 9.1. QFN24 Package Drawing

Table 9.1. QFN24 Package Dimensions

Dimension	Min	Тур	Max
А	0.8	0.85	0.9
A1	0.00	_	0.05
A2	_	0.65	_
A3	0.203 REF		
b	0.15	0.2	0.25
b1	0.25	0.3	0.35
D	3.00 BSC		
Е	3.00 BSC		

10.3 QSOP24 Package Marking



Figure 10.3. QSOP24 Package Marking

The package marking consists of:

- PPPPPPP The part number designation.
- TTTTTT A trace or manufacturing code.
- YY The last 2 digits of the assembly year.
- WW The 2-digit workweek when the device was assembled.
- # The device revision (A, B, etc.).

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